FIZ3630 SOLAR CELLS 2023-2024 FALL SEMESTER & Friday 17.00

- Energy Sources, Solar Energy, and Greenhouse Effect
- Solar Radiation, Solar Spectrum
- Interaction of light and matter
- Semiconductors
- Photovoltaic Effect
- pn Junctions
- Basic Structure of Solar Cells
- Midterm Exam
- Solar Cells Parameters
- Effects on Solar Cells Parameters
- Characterization of Solar Cells
- Historical Development and Classification of Solar Cells
- Concepts for Improving the Efficiency of Solar Cells
- Summary, Exercises
- Final Exam

- WEEK 1 (06/10/2023)
- WEEK 2 (13/10/2023)
- WEEK 3 (20/10/2023)
- WEEK 4 (27/10/2023)
- WEEK 5 (03/11/2023)
- WEEK 6 (10/11/2023)
- WEEK 7 (17/11/2023)
- WEEK 8 (24/11/2023)
- $\frac{1}{2} \frac{1}{2} \frac{1}$
- WEEK 9 (01/12/2023)
- WEEK 10 (08/12/2023)
- WEEK 11 (15/12/2023)
- WEEK 12 (22/12/2023)
- WEEK 13 (29/12/2023)
- WEEK 14 (05/01/2024)
- WEEK 15 (12/01/2024)

Light Management in Solar Cells: The Big Picture





Buonassisi (MIT) 2011

Low-Energy Photon-Matter Interactions

At low energies typical for visible light, photons interact primarily with valence electrons.

Interactions of Visible Light with Matter

Interactions of visible light with matter can be described by the *complex index of refraction*:

 $n_{c} = n + ik$ Real component index of refraction (phase velocity) Imaginary componentextinction coefficient(attenuation) $<math display="block">\alpha = \frac{4\pi k}{\lambda}$ absorption coefficient

Linearly polarised

Courtesy of HOLMARC

Real and Imaginary components of the index of refraction are wavelength-dependent, and are typically measured using a measurement technique called *spectroscopic ellipsometry*.

Photons – Reflections off a Surface

At visible wavelengths, the fraction of reflected light depends most strongly on real component of the index of refraction.

$$R = \left(\frac{(n-1)^2 + k^2}{(n+1)^2 + k^2}\right)$$



Reflectance from air (n_{air}=1) to a solid with n.

we want to minimize the reflection !



Tinted windows

0

- Why can't you see inside?
- If the glass pane was flipped, would this change anything?



https://www.amazon.com/Blocking-Tinting-Privacy-Reflective-Adhesive/dp/B0BNQ29GCY?th=1

Bulk Absorption





surface reflection absorption scattering







absorption events

- may result in generation of free charge.
- may just heat material up and generate phonons.

absorption coefficient : α is a function of the wavelength of light and property of the medium. $\sigma N = \alpha$ vary as a <u>function of wavelength</u> inside of a material due to the physical absorption mechanisms are varying as a function of wavelength.



Polycrystalline

silicon solar cell



https://www.digikey.pl/pl/producthighlight/p/panasonic/amorphoussilicon-solar-cells



Yin, Xingtian, et al. "19.2% Efficient InP heterojunction solar cell with electronselective TiO2 contact." ACS photonics 1.12 (2014): 1245-1250.



Kenning, T. "Alta Devices sets GaAs solar cell efficiency record at 29.1%, joins NASA space station testing." (2018).



Yin, Wan-Jian, Tingting Shi, and Yanfa Yan Advanced materials 26.27 (2014): 4653-4658.



https://www.energy.gov/eere/ solar/perovskite-solar-cells

Saga, Tatsuo. "Advances in crystalline silicon solar cell technology for industrial mass production." npg asia materials 2.3 (2010): 96-102.

Monocrystalline

silicon solar cell

Methods to Minimize Optical Losses : Light Management

- Antireflection coatings (ARCs)
- Snell's Law
- Texturization
- Back surface reflection, total internal reflection

Anti-Reflection Coatings





no light transmitted into semiconductor



Anti-Reflection Coatings

The thickness of ARC is chosen so that wavelength in the dielectric material is one quarter the wavelength of the incoming wave.

Silicon has a high surface reflection of over 30%. The reflection is reduced by texturing and ARC !



G. Bauer, "Absolutwerte der optischen Absorptionskonstanten von Alkalihalogenidkristallen im Gebiet ihrer ultravioletten Eigenfrequenzen", Annalen der Physik, vol. 411, no. 4, pp. 434 - 464, 1934.



Qualities of an optimized ARC:

- Index of refraction between absorber and superstrate (air, glass)
- Thickness on the order of a quarter wavelength
- Stable
- Enhances electrical performance by passivating dangling bonds at the surface and repelling charges from the surface

Thickness of Anti-Reflection Coatings



Four multicrystalline wafers covered with films of silicon nitride. The difference in color is solely due to the thickness of the film. The green wafers are very thick films and so don't appear in the color chart of the below figure.



https://www.pveducation.org/pvcdrom/design-of-silicon-cells/anti-reflection-coating-color

Spectral Reflectivity for Optimized SiN_x optimized at 550nm



Color Chart for Films of SiO₂ under fluorescent lighting

Film _{Thickness} (µm)	Colour
0.05	Tan
0.07	Brown
0.20	Light gold to yellow; slightly metallic
0.22	Gold with slight yellow orange
0.25	Orange to melon
0.27	Red violet
0.30	Blue to violet blue
0.42	Carnation pink
0.72	Blue green to green (quite broad)
1.19	Red Violet
1.21	Violet red
1.24	Carnation pink to salmon
1.25	Orange
1.28	"Yellowish"
1.32	Sky blue to green blue
1.40	Orange
1.45	Violet
1.54	Dull yellow green

Texturization

Multiple reflections on surface:

- Increase probability that light enters device.
- Increase effective path length of incoming light.



A square based pyramid which forms the surface of an appropriately textured crystalline silicon solar cell.



Scanning electron microscope photograph of a textured silicon surface. Image Courtesy of The School of Photovoltaic & Renewable Energy Engineering, University of New South Wales.

https://www.pveducation.org/pvcdrom/design-of-silicon-cells/surface-texturing



The reflected light from the surface, RI, is reflected at the same angle at which the incoming light strikes the surface.



S. C. Baker-Finch, McIntosh, K. R., and Terry, M. L., "Isotextured Silicon Solar Cell Analysis and Modeling 1: Optics", IEEE Journal of Photovoltaics, vol. 2, no. 4, pp. 457 - 464, 2012.



Scanning electron microscope photograph of a textured multicrystalline silicon surface. Image Courtesy of The School of Photovoltaic & Renewable Energy Engineering, University of New South Wales.



B. Textured Back Surface



Angles from normal incident: 0.1° reflected: 0.1° refracted: 0.0°	air refractive index: 1.0
	silicon, refractive index: 3.5 silicon glass

Rearranging Snell's law, angle at which light enters the solar cell (the angle of refracted light) can be calculated:

$$\theta_2 = \sin^{-1}\left(\frac{n_1}{n_2}\sin\theta_1\right)$$

In a textured single c-Si solar cell, the presence of crystallographic planes make the angle θ_1 equal to 36°



Back surface reflection, Total internal reflection

The amount of light reflected at an interface is calculated from the fresnel reflection formula.

If light passes from a high refractive index medium to a low refractive index medium, there is possibility of total internal reflection (TIR).

The angle at which this occurs is the critical angle and is found by setting θ_2 in Snell's law to 0.

$$\theta_1 = \sin^{-1}\left(\frac{n_2}{n_1}\right)$$

Lambertian Rear Reflectors



random reflector on rear of cell

Back surface reflection, Total Internal Reflection



A. Textured Busbar

White backskin, textured busbar on modules helps with light capture (via total internal reflection)!

There is a limit for light trapping!

Yablonovitch Limit

4n² = maximum increase in optical path length

B. Textured Back Surface





Light Management is Necessary



- increases absorptance
- ✓ minimizes reflectance
- ensures light trapping

Using total internal reflection, light can be trapped inside the cell and make multiple passes through the cell, thus allowing even a thin solar cell to maintain a high optical path length.

Additionally we can

- □ change wavelength of incoming light to enhance optical absorption coefficient.
- □ change optical absorption coefficient of material by manipulating band structure.

Table presents the common semiconductor materials for solar cells and their properites at the center of the visible-light spectrum. To achieve a total absorption of 95% investigate the required semiconductor thicknesses for each material.

Material	Ge	CulnSe ₂	Si	GaAs	CdTe
Туре	indirect	direct	indirect	direct	direct
E _G (eV)	0.67	1.04	1.11	1.43	1.49
Absorption edge (µm)	1.85	1.19	1.12	0.87	0.83
Absorption coeficient (cm ⁻¹)	5.0 10 ⁴	1.0 10 ⁵	1.0 10 ³	1.5 10 ⁴	3.0 10 ⁴



Beer Lambert Law: $I = I_o e^{-\alpha l}$ 95% absorption *I*=0.05 and $I_o = 1.00$

$$-\alpha l = \ln\left(\frac{l}{l_0}\right) \quad l = -\frac{1}{\alpha} ln\left(\frac{l}{l_0}\right) = -\frac{1}{\alpha}(-2.996) = \frac{2.996}{\alpha}$$

$$l_{Ge} = \frac{2.996}{5.0\ 10^4} cm = 0.5992\ 10^{-6}m = 0.6\ \mu m$$

$$l_{CuInSe2} = \frac{2.996}{1.0\ 10^5} cm = 2.996\ 10^{-7}m = 0.3\ \mu m$$

$$l_{Si} = \frac{2.996}{1.0\ 10^3} cm = 2.996\ 10^{-5}m = 30\ \mu m$$

$$l_{GaAs} = \frac{2.996}{1.5\ 10^4} cm = 1.997\ 10^{-6}m = 2.0\ \mu m$$

$$l_{CdTe} = \frac{2.996}{3.0\ 10^4} cm = 0.9986\ 10^{-6}m = 1.0\ \mu m$$

A 100 µm thick Si solar cell is covered with an ARC and exposed to illumination with a single wavelength 600 nm and constant light intensity. Absorption coefficient of Si is given as 3.88 10⁴ cm⁻¹ for this condition, find the absorbed light percentage at 1000 nm distance from the surface.

Beer Lambert Law: $I = I_o e^{-\alpha l}$

At the surface
$$L=0$$
; $I = I_o$
At $L = 1 \ \mu m = 10^{-4} cm$; $I = I_o e^{-\alpha L} = I_o e^{-3.88 \ 10^4 \ 10^{-4}}$
 $I = I_o e^{-3.88} = 0.02 \ I_o$ 98% of light absorbed

Consider a Si solar cell (n_{Si} =3.50) coated with a layer of silicon dioxide (n_{SiO2} =1.45) ARC to maximize the efficiency. Calculate the minimum ARC thickness that will minimize the reflection at the wavelength of 705 nm where the solar cell is most efficient.

for destructive interference we found the optimum thickness formula for ARC;

$$d_{ARC} = \frac{\lambda_0}{4n_{ARC}} = \frac{705 \ nm}{4 \ 1.45}$$
$$d_{ARC} = 121.55 \ nm$$

GaAs is a semiconductor with a band gap of 1.43 eV. Find the maximum wavelength of photons required to excite electrons from the valance band to the conduction bandn of GaAs?

$$E = \frac{hc}{\lambda}$$

$$\lambda = \frac{hc}{E} = \frac{1240}{1.43 \ eV} eV \ nm = 867.1 \ nm$$